

Notice of References Cited	Application/Control No. 10/775,155		Applicant(s)/Patent Under Reexamination MIYASHITA ET AL.	
	Examiner RICARDO L. OSORIO		Art Unit 2629	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-6,909,597	06-2005	Tutikawa, Yoshiji	361/681
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*	D	US-6,081,207	06-2000	Batio, Jeffry	341/20
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	L	US-			
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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